

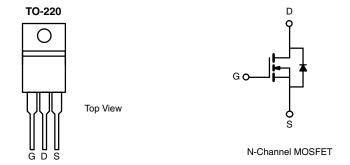
K100E10N1-VB Datasheet N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	100				
$R_{DS(on)}(\Omega)$ at $V_{GS} = 10 \text{ V}$	0.0030				
I _D (A) ^a	180				
Configuration	Single				

FEATURES

- TrenchFET® Power MOSFET
- Package with Low Thermal Resistance
- AEC-Q101 Qualifiedd
- \bullet 100 % R_g and UIS Tested





ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	100	V	
Gate-Source Voltage		V _{GS}	± 20	V	
Continuous Drain Current	T _C = 25 °C ^a	1	180		
	T _C = 125 °C	l _D	140		
Continuous Source Current (Diode Conduction) ^a		I _S	180	Α	
ulsed Drain Current ^b		I _{DM}	480		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	73		
Single Pulse Avalanche Energy	L=0.11IIH	E _{AS}	266	mJ	
Maximum Power Dissipation ^b	T _C = 25 °C	P _D	250	W	
	T _C = 125 °C		83	VV	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	LIMIT	UNIT		
Junction-to-Ambient P	CB Mount ^c	R_{thJA}	40	°C/W		
Junction-to-Case (Drain)		R_{thJC}	0.6	C/VV		

Notes

- a. Base on Tc = 25°C.
- b. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- c. When mounted on 1" square PCB (FR-4 material).
- d. Parametric verification ongoing.

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PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT		
Static								
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0, I_D = 250 \mu A$		100	-	-		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		2.5	3.0	3.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA	
		V _{GS} = 0 V	V _{DS} = 100 V	-	-	1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V	V _{DS} = 100 V, T _J = 125 °C	=	-	50	μΑ	
		V _{GS} = 0 V	V _{DS} = 100 V, T _J = 175 °C	-	-	500		
On-State Drain Current ^a	I _{D(on)}	V _{GS} = 10 V	$V_{DS} \ge 5 V$	120	-	-	Α	
Drain-Source On-State Resistance ^a		V _{GS} = 10 V	I _D = 20 A	=	0.0030	-		
	R _{DS(on)}	V _{GS} = 10 V	I _D = 20 A, T _J = 125 °C	=	0.0064	-	Ω	
		V _{GS} = 10 V	I _D = 20 A, T _J = 175 °C	-	0.0080	-		
Forward Transconductance ^b	9 _{fs}	V _{DS} = 15 V, I _D = 20 A		=	82	-	S	
Dynamic ^b								
Input Capacitance	C _{iss}			=	5780	7230		
Output Capacitance	C _{oss}	$V_{GS} = 0 V$	$V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	=	3070	3840	pF	
Reverse Transfer Capacitance	C _{rss}	1		=	305	385		
Total Gate Charge ^c	Qg			=	125	190		
Gate-Source Charge ^c	Q_{gs}	V _{GS} = 10 V	$V_{DS} = 50 \text{ V}, I_{D} = 70 \text{ A}$	=	28	-	nC	
Gate-Drain Charge ^c	Q_{gd}	1			46	-	1	
Gate Resistance	R_g		f = 1 MHz		3.3	5	Ω	
Turn-On Delay Time ^c	t _{d(on)}	$V_{DD} = 50 \text{ V}, \text{ R}_L = 0.7 \Omega$ $I_D \cong 70 \text{ A}, \text{ V}_{GEN} = 10 \text{ V}, \text{ R}_g = 1 \Omega$		-	16	25		
Rise Time ^c	t _r			=	110	165	ns	
Turn-Off Delay Time ^c	t _{d(off)}			=	40	60		
Fall Time ^c	t _f			-	12	20		
Source-Drain Diode Ratings and Chara	acteristics ^b							
Pulsed Current ^a	I _{SM}			-	-	480	Α	
Forward Voltage	V_{SD}	I _F = 100 A, V _{GS} = 0		-	0.9	1.5	V	

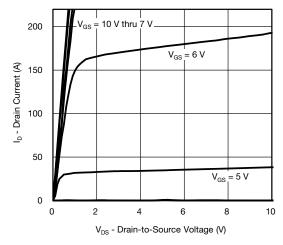
Notes

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

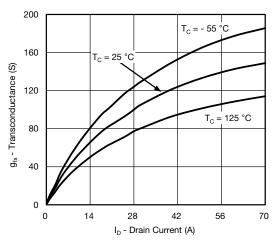
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



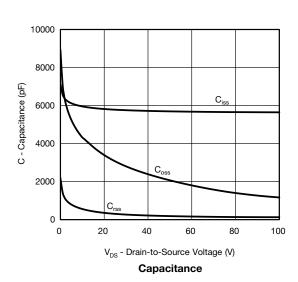
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)

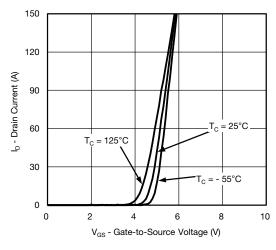


Output Characteristics

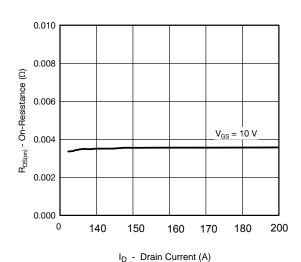


Transconductance

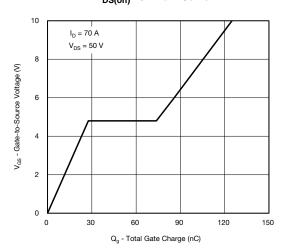




Transfer Characteristics



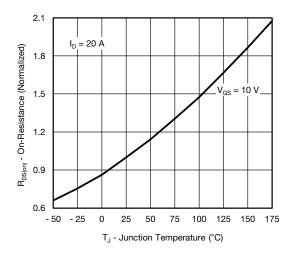
R_{DS(on)} vs. Drain Current



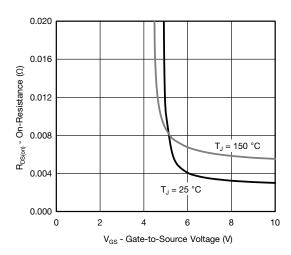
Gate Charge



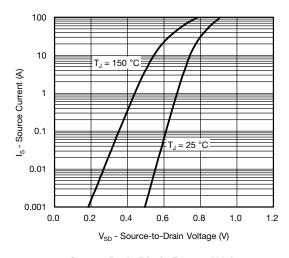
TYPICAL CHARACTERISTICS ($T_A = 25 \, ^{\circ}\text{C}$, unless otherwise noted)



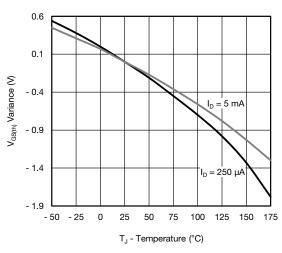
On-Resistance vs. Junction Temperature



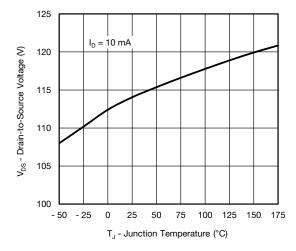
On-Resistance vs. Gate-to-Source Voltage



Source Drain Diode Forward Voltage



Threshold Voltage

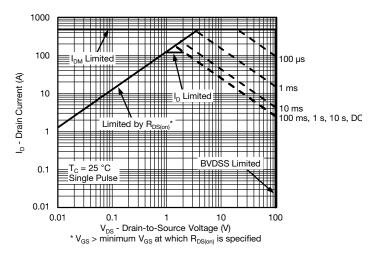


Drain Source Breakdown vs. Junction Temperature

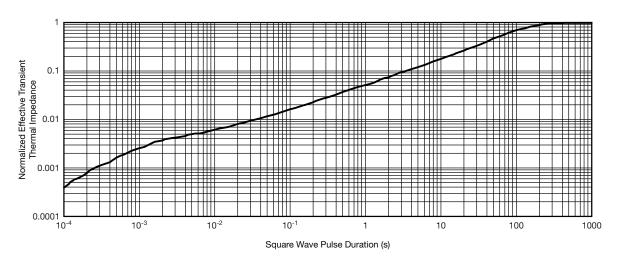
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THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)



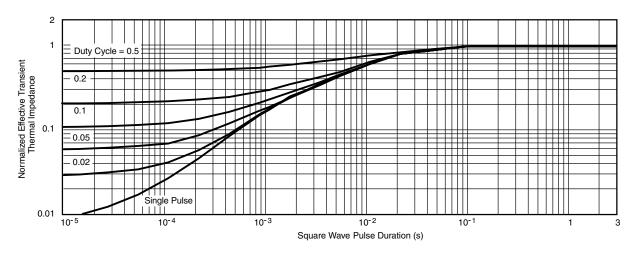
Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Ambient



THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

Note

- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction to Ambient (25 °C)
 - Normalized Transient Thermal Impedance Junction to Case (25 °C) are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.

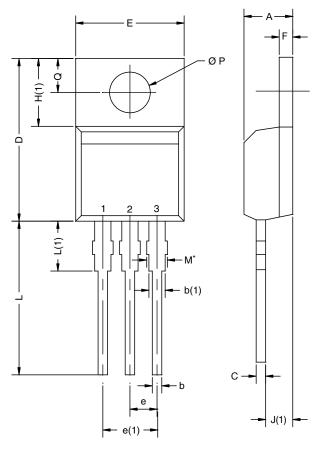


INCHES

MIN.

TO-220AB

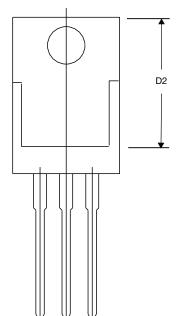
DIM.



25 69 20	4.65 1.01	0.167 0.027	0.183			
		0.027				
20		1 -:	0.040			
	1.73	0.047	0.068			
36	0.61	0.014	0.024			
.85	15.49	0.585	0.610			
.19	12.70	0.480	0.500			
.04	10.51	0.395	0.414			
41	2.67	0.095	0.105			
88	5.28	0.192	0.208			
14	1.40	0.045	0.055			
09	6.48	0.240	0.255			
41	2.92	0.095	0.115			
.35	14.02	0.526	0.552			
32	3.82	0.131	0.150			
54	3.94	0.139	0.155			
60	3.00	0.102	0.118			
ev. P, 1	16-Jun-14					
	·		·			
	mm (dimen	sion includin	g protrusion)			
Heatsink hole for HVM						
			o 1.62 mm (dimension includin /M			

MILLIMETERS

MAX.





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